



<b>Title of Change:</b>	ON Carmona, Philippines new probe location site addition for Part NLHV4157N.	
<b>Proposed first ship date:</b>	23 January 2020	
<b>Contact information:</b>	Contact your local ON Semiconductor Sales Office or <Ovidiu.Tol@onsemi.com>	
<b>Samples:</b>	Contact your local ON Semiconductor Sales Office or <PCN.samples@onsemi.com> Sample requests are to be submitted no later than 30 days from the date of first notification, Initial PCN or Final PCN, for this change. Samples delivery timing will be subject to request date, sample quantity and special customer packing/label requirements.	
<b>Additional Reliability Data:</b>	Contact your local ON Semiconductor Sales Office	
<b>Type of notification:</b>	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact <PCN.Support@onsemi.com>	
<b>Change Part Identification:</b>	Date code will identify unit with this change.	
<b>Change Category:</b>	<input type="checkbox"/> Wafer Fab Change <input type="checkbox"/> Assembly Change <input type="checkbox"/> Test Change <input checked="" type="checkbox"/> Other <u>PROBE</u>	
<b>Change Sub-Category(s):</b>	<input type="checkbox"/> Manufacturing Site Addition <input type="checkbox"/> Material Change <input type="checkbox"/> Datasheet/Product Doc change <input type="checkbox"/> Manufacturing Site Transfer <input type="checkbox"/> Product specific change <input type="checkbox"/> Shipping/Packaging/Marking <input checked="" type="checkbox"/> Manufacturing Process Change <input checked="" type="checkbox"/> Other: <u>PROBE</u>	
<b>Sites Affected:</b>	ON Semiconductor Sites: ON Carmona, Philippines	External Foundry/Subcon Sites: None
<b>Description and Purpose:</b>		
ON Semiconductor would like to inform its customers for the addition of a sort insertion in the test flow for NLHV4157.		
	<b>Before Change Description</b>	<b>After Change Description</b>
Probe Location	N/A	ON Carmona, Philippines
There are no product material changes as a result of this change.		
There is no product marking change as a result of this change.		
<b>Reliability Data Summary:</b> There is no Reliability required for the implementation of a sort insertion in the test flow for NLHV4157.		
<b>Electrical Characteristic Summary:</b> Electrical characteristics are not impacted.		
<b>List of Affected Parts:</b>		
<b>Note:</b> Only the standard (off the shelf) part numbers are listed in the parts list. Any custom parts affected by this PCN are shown in the customer specific PCN addendum in the PCN email notification, or on the <u>PCN Customized Portal</u> .		
<b>Part Number</b>	<b>Qualification Vehicle</b>	
NLHV4157NDFT2G	NLHV4157NDFT2G	